Wire Wound Chip Inductor



Features

- 1. Small chip suitable for surface mounting:
- 2. High Q value and high self-resonant frequency with ceramic material:
- 3. Tight inductance tolerance and stable inductance; at high frequency;
- 4. RoHS Compliant.



Application

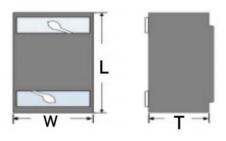
- 1. High frequency circuit in telecommunication and other equipments;
- 2 Mobile phones such as GSM, CDMA, PDC, etc:
- 3、Bluetooth, W-LAN, Broadband network。

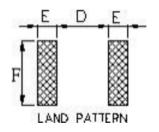
◆ PRODUCT IDENTIFICATION

SCW 1608 Q 1R0 M S T (1) (2) (3) (4) (5) (6) (7)

- (1) Series Type
- (2) Chip Size (mm): Length X Width
- (3) Material Code
- (4) Inductance: 1R0=1.0uH 100=10uH Inductance Tolerance: J= \pm 5%; K= \pm 10%; M \pm 20%;
 - (5) Company Code
 - (6) Packaging: Tape Carrier Package

◆ SHAPE AND DIMENSIONS (unit: mm)





Series	L	W	Т	Е	F	D
SCW1608Q	1.60 ± 0.15	1.1 ± 0.15	1.0±0.15	0.64Typ	1.02Typ.	0.64Typ.

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Specification

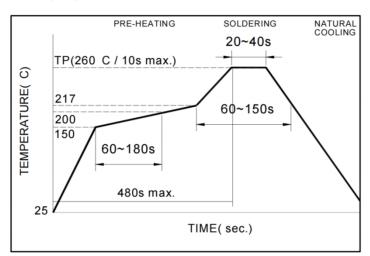
Book Novel on	Inductance	Test Condition	Q	SRF (Min.)	DCR ±30%	lsat (Typ)	Irms (Typ)
Part Number	uH	MHz	(Тур)	MHz	Ω(Max)	mA	mA
SCW1608Q1R0MST	1.0±20%	1.0	9	350	0.21	1100	720
SCW1608Q1R5MST	1.5±20%	1.0	9	300	0.39	650	520
SCW1608Q2R2MST	2.2±20%	1.0	9	250	0.46	680	480
SCW1608Q4R7MST	4.7±20%	1.0	9	100	0.7	450	400
SCW1608Q6R8MST	6.8±20%	1.0	9	50	1.25	360	300
SCW1608Q100MST	10±20%	1.0	9	25	1.3	270	380
SCW1608Q150MST	15±20%	1.0	9	25	2.0	270	230
SCW1608Q220MST	22±20%	1.0	9	10	3.9	220	160

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SOLDERING CONDITIONS

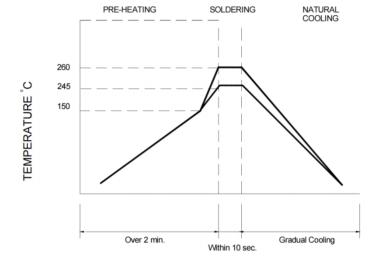
Figure 1. Re-flow Soldering (Lead Free)



Note:

- ·Preheat circuit and products to 150° C
- ·260°C tip temperature (max)

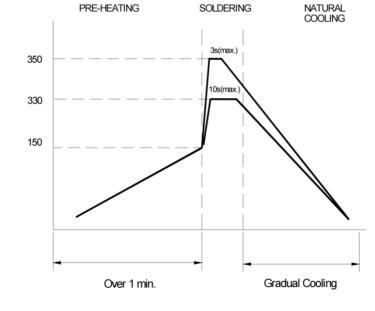
Figure 2. Wave Soldering



Note:

- ·Never contact the ceramic with the iron tip
- ·1.0mm tip diameter (max)

Figure 3. Hand Soldering



Note:

- ·Use a 20 watt soldering iron with tip diameter of 1.0mm
- ·Limit soldering time to 3 sec.



♦ RELIABILITY TEST

TEST ITEM	SPECIFICATION	TEST CONDITION	
Rating current	According to product specifications	Current sources:33010D	
Inductance	According to product specifications	Test Frequency:0.252~250MHz Test Equipment:HP4291A 、 HP4286A 、 HP4287A 、 HP4284A Test Fixture:16193Aor16334A	
Q	According to product specifications	Test Frequency:0.252~1500MHz Test Equipment:HP4291A、HP4286A、HP4287A Test Fixture:16193Aor16334A	
RDC	According to product specifications	Test Equipment:HP4263B	
SRF	According to product specifications	Test Equipment:HP4291A Test Fixture:16193A	
Solderability	The metalized area must have more then 90% of solder coverage	Soldering Temp:230±5°C Dipping time:5±1S	
Resistance to soldering heat	No evidence of mechanical damage The mealized arer must have more then 75% of solder coverage Inductance change,less than±5% Q change less than±10%	Soldering Temp:260±5°C Dipping time:10±1S	
Thermal Shock No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%		A cycle contain:Step1:-40°C, 30Min Step 2:85°C, 30Min Cycle Times:10	

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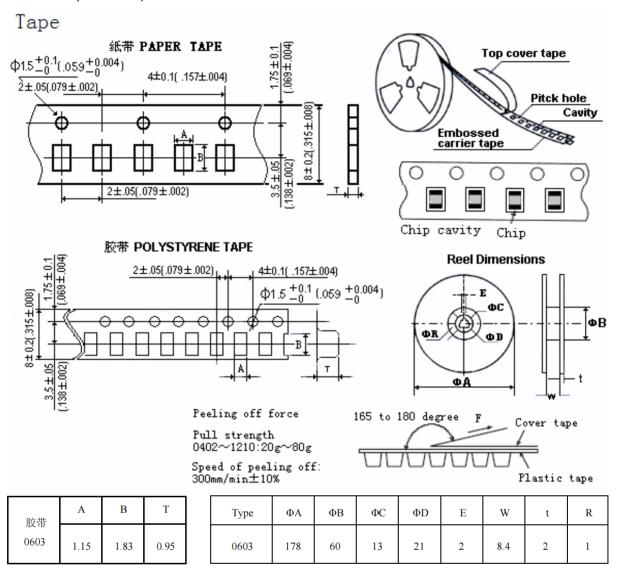


TEST ITEM	SPECIFICATION	TEST CONDITION
High Temperature Storage	No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%	Test Temperature: 125±2°C(Ceramiccore)85±2°C(Ferrite core) Test Time: 96±2Hours
Low Temperature Storage	No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%	Test Temperature:-40±2°C Test Time:96±2Hours
Moisture Resistance	No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%	Test Temperature:50±2°C Test Time:100Hours relative humidity:90~95%
Vibration	No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%	Amplitude:1.5mm X、Y、Z each direction for 1Hour and 45min Frequency range:10~55~10Hz(min)
Component Adhesion	No evidence of mechanical damage No evidence of peel off or broken Keep coutinuity of Winding	Force:2Kg Test Time:5±1sec
Resistance to bend	No evidence of mechanical damage	Camber:20mm Test Board:Glass-Epoxy board Thickness:8mm Pressure jig R230 F
Life	No evidence of mechanical damage, Inductance change less than±5%, Q change less than±10%	Test Temperature:85±2°C Test Time:1000Hours with rating current

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◆ PACKAGING(unit: mm)



PACKAGING QUANTITY

Size	SCW1608Q Series
Quantity(pcs)	4,000

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